

Search Notes



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Examiner

Shih-wen Hsieh

Applicant(s)/Patent under
Reexamination

UMEDA ET AL.

Art Unit

2861

SEARCHED

Class	Subclass	Date	Examiner
updated	updated	3/3/2005	<i>SWH</i> SWH

INTERFERENCE SEARCHED

Class	Subclass	Date	Examiner
347	30,29	3/3/2005	<i>SWH</i> SWH
347	32	3/3/2005	<i>SWH</i> SWH

SEARCH NOTES (INCLUDING SEARCH STRATEGY)

	DATE	EXMR